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**INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

SN/T 2004.4-2006

**Determination of Lead, Cadmium, Chromium and Mercury in
electrical and electronic equipment. Part 4: Inductively coupled
plasma atomic emission spectrometric method**

电子电气产品中铅、镉、铬、汞的测定 第4部分
(English Translation)

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What this standard covers

This standard specifies the inductively coupled plasma atomic emission spectrometry (ICP-AES) Determination of polymer electronic products (except PTFE), metal materials, electronic components, lead (Pb), cadmium (Cd), chromium (Cr) and mercury (Hg) method. This standard applies to electrical and electronic products Polymer (except PTFE), metal materials, electronic components, lead (Pb), chromium (Cr) and mercury (Hg) the determination of the detection limit of each element as shown in Table 1 shown.

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